Search Notes					

Application/Control No.	Applicant(s)/Patent under Reexamination
10/562,557	SHINKAI ET AL.
Examiner	Art Unit
TUYEN T. NGUYEN	2832

	SEARCHED			
Class	Subclass	Date	Examiner	
336	65, 83, 200, 206- 208, 232- 234	7/9/2006	TTN	

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
see Ea	st note	7/9/2006	TTN

SEARCH NOT (INCLUDING SEARCH	ES STRATEGY)
	DATE	EXMR
	,	